

School of Mathematical Sciences Discipline of Applied Mathematics

# **Financial Risk Measures**

— The Theory and Applications of Backward Stochastic Difference/Differential Equations with respect to the Single Jump Process

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Thesis submitted for the degree of Doctor of Philosophy

May 2012

ii

# Contents

Abstract Signed Statement					
					A
D	edica	tion		xi	
1	Intr	oducti	ion	1	
	1.1	Overv	iew	1	
	1.2	Risk n	neasures in mathematical finance	2	
		1.2.1	Static risk measures	2	
		1.2.2	Value-at-Risk	3	
		1.2.3	Conditional Value-at-Risk	3	
		1.2.4	Dynamic risk measures and BSDE	4	
	1.3	Single	jump process	7	
		1.3.1	The continuous finite time single jump process	7	
		1.3.2	The discrete finite time single jump process $\ldots \ldots \ldots \ldots$	7	
	1.4	Struct	ure of this thesis	8	
Ι	Th	neory		9	
<b>2</b>	2 Discrete Time			11	
3	3 Continuous Time			31	

Π	Applications	55	
4	Discrete Time	57	
5	Continuous Time	65	
Bi	Bibliography		

#### Abstract

This thesis studies financial risk measures which dynamically assign a value to a risk at a future date which can be interpreted as the present value of a future monetary value. In particular, the theories of backward stochastic difference equations in discrete time and differential equations in continuous time (BSDE) with respect to a single jump process are developed. Based on these theories, some associated dynamic risk measures are defined.

Chapter 1 is an introduction to the background of BSDEs, risk measures, and the single jump process, and also outlines the structure of this thesis.

Part I considers backward stochastic difference equations related to a discrete finite time single jump process (Chapter 2) and backward stochastic differential equations related to a finite continuous time single jump process (Chapter 3). We prove the existence and uniqueness of solutions of these BSDEs under some assumptions. Comparison Theorems for these solutions are also given. Applications to the theory of nonlinear expectations are then investigated.

Part II considers some applications of the theories established in Part I. In Chapter 4, risk measures related to the solutions of backward stochastic difference equations with respect to a discrete time single jump process are defined and some simple numerical examples are given. In Chapter 5, we consider the question of an optimal transaction between two investors to minimize their risks. We define a dynamic entropic risk measure using backward stochastic differential equations related to a continuous time single jump process. The inf-convolution of dynamic entropic risk measures is a key transformation in solving the optimization problem.

## Signed Statement

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#### Published works within this thesis

Shen, Leo and Elliott, R.J., Backward Stochastic Difference Equations For A Single Jump Process, *Methodology and Computing in Applied Probability*, to appear. Published online Feb, 2011: http://dx.doi.org/10.1007/s11009-011-9217-z.

Shen, Leo and Elliott, R.J., Backward Stochastic Differential Equations With A Single Jump Process, *Stochastic Analysis and Applications* **29**(4)(2011), 654–673.

Shen, Leo and Elliott, R.J., How To Measure Risk, *Expert Systems With Applications* **39**(5)(2012), 6111–6115.

Shen, Leo and Elliott, R.J., Optimal Design Of Dynamic Default Risk Measures, accepted on 01 May 2012 and scheduled for publication in *Journal of Applied Probability* Vol.49 No.4 (December 2012).

### Acknowledgements

I am particularly grateful to my supervisor Professor Robert Elliott for sharing his wide knowledge and for his teaching and support. I wish also to thank Associate Professor John van der Hoek and Dr. Samuel Cohen for their encouragement. Various people in the School of Mathematics at Adelaide University deserve thanks for their helps, especially Professor Charles Pearce, Dr. Alexei Filinkov, Dr. Trent Mattner and Dr. Elizabeth Cousins. I would like to thank my parents, my wife Amy and my sons Evan and Owen. Owen is the best "paper" I wrote during my PhD candidature.

# Dedication

To Amy